SVT Workfest Summary

Ernst Sichtermann (LBNL)

SVT - for reference

Inner Barrel (IB)

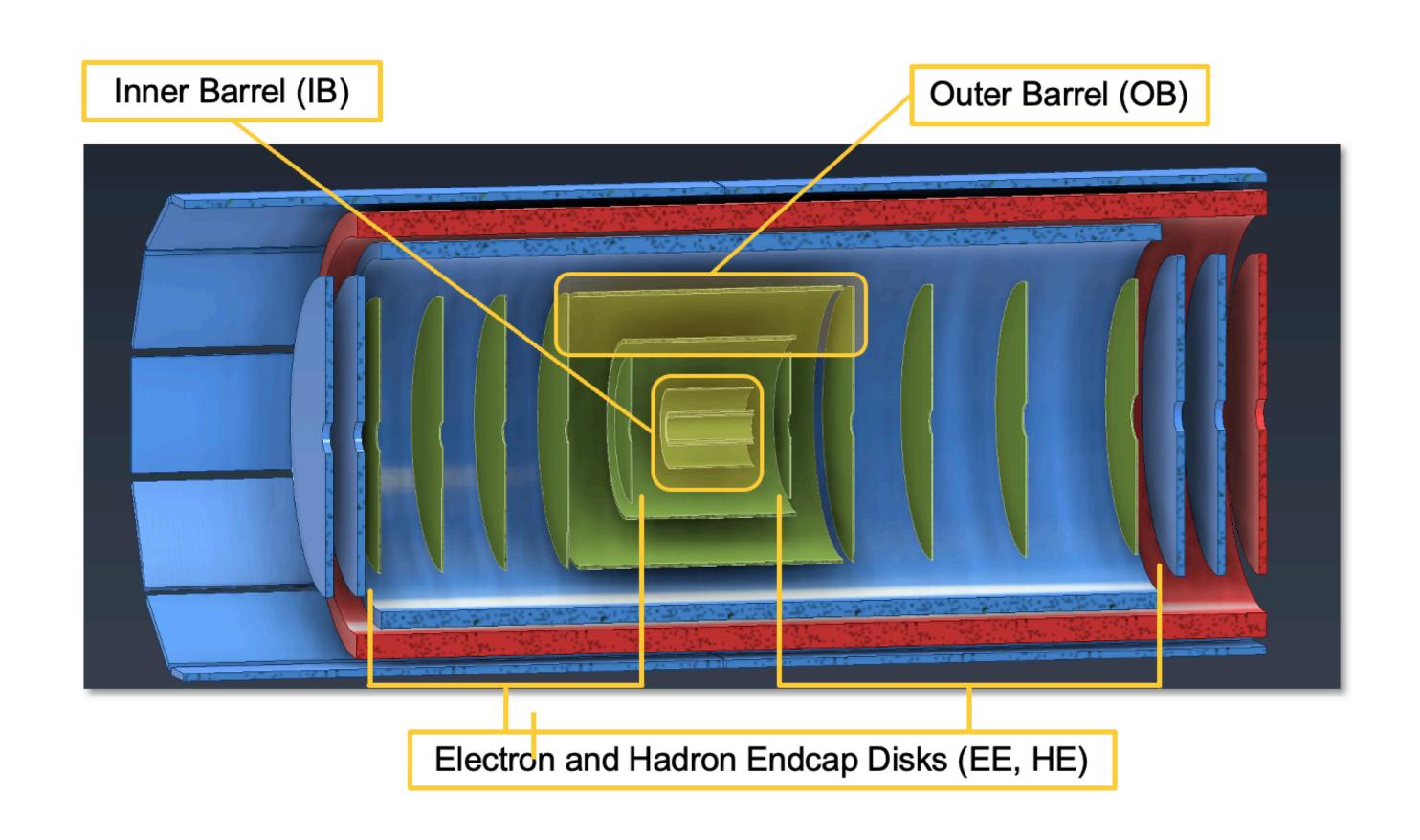
- Three layers, L0, L1, L2,
- Radii of 36, 41, 120 mm
- Length of 27 cm
- $X/X_0 \sim 0.05\%$ per layer
- Curved, thinned, wafer-scale sensor

Outer Barrel (OB)

- Two layers, L3, L4
- Radii of 27 and 42 cm
- $X/X_0 \sim 0.25\%$ and $\sim 0.55\%$
- More conventional structure w. staves

• Electron/Hadron Endcaps (EE, HE)

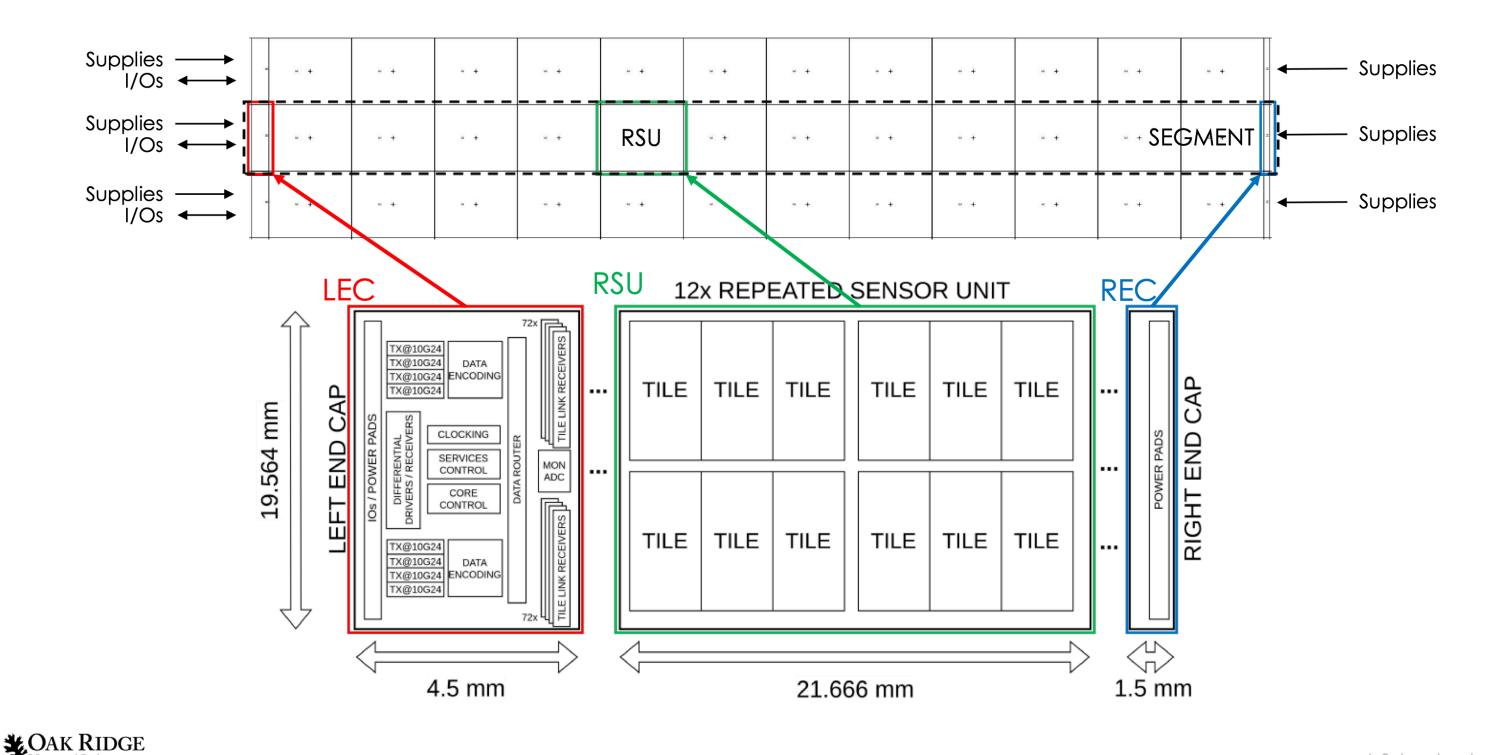
- Two arrays with five disks
- X/X₀ ~0.25% per disk
- More conventional structure



Lengths for L2—L4 increase so as to project back to z = 0; disk radii adjust accordingly

SVT - for reference

MOSAIX Architecture



J. Schambach

SVT heavily relies on MOSAIX development for ALICE-ITS3 at CERN,

- Inner Barrel: same sensor,
- Outer Barrel and Disks: EIC large-area sensor identical pixel matrix, changes to endcap (and number of RSUs)
- Ancillary IC to provide (serial) powering of all domains, bias voltage, and service reduction for slow control.

SVT Workfest — 2024 ePIC Summer Mtg.

Half-day workfest:

- Thursday morning so as to facilitate remote participation
- Featured inner barrel, readout, beam-tests and irradiation, services
- Indico: https://indico.bnl.gov/event/20727/sessions/7434/#20240725

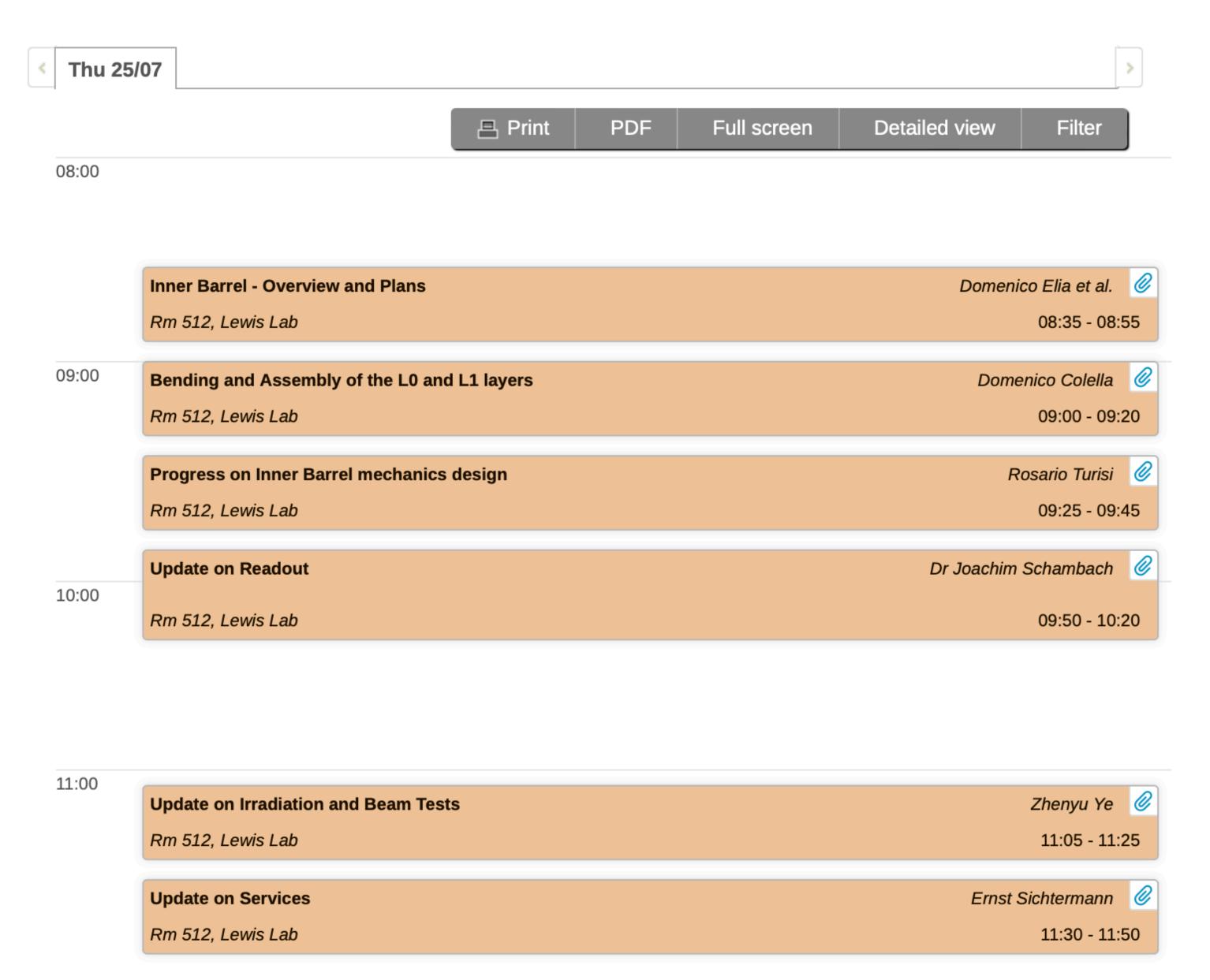
Smaller scale Workfest was productive — as intended

Success Factors:

- everyone who actively participated in person and remote
- in-person interactions workfest and throughout the meeting,
- · well-prepared parallel-session style talks with a wealth of information,

Thanks to all who participated and local organization!

SVT Workfest: Thursday July 25, 2024



Domenico Elia

SVT Workfest — Inner Barrel





SVT IB interests & contributions

Latest figure @ April 2024 SVT general meeting:

- integrated design of the 3 innermost layers including mechanics, cooling, readout and powering, up to the electrical/optical interface:
 - develop bending procedure, eg L0 (similar for L1)
 - extend to L2 considering additional issues
 - design L0/L1 and L2 support structures
 - integration of the cooling needs
 - development of the edge FPC(s)
- choice of the cooling:
 - simulation studies with ANSYS
- thermo-mechanical prototypes:
 - build prototypes for both L0/L1 and L2
 - perform dedicated tests of prototypes in wind tunnel
 - test of embedded silicon thermal properties in a thermal chamber

Mir

Physics

- support structure within the subsystem to keep everything together
 - connection of L0/L1 to L2
 - explore needs for a (light) supporting external shell (to L2)









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Physics



















Rosario Turrisi

SVT Workfest — Inner Barrel

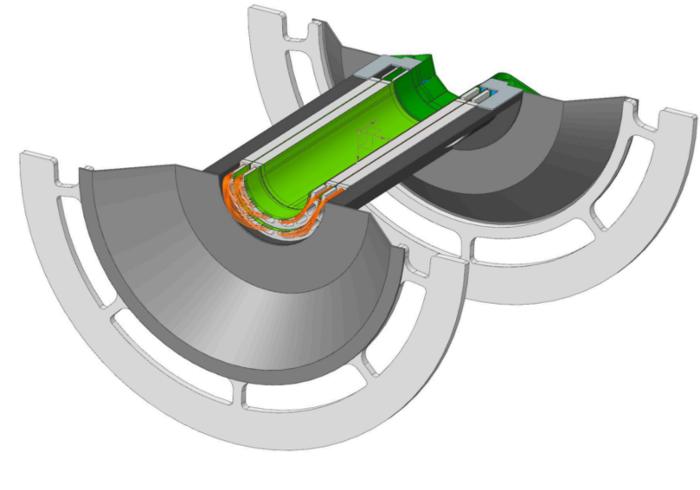


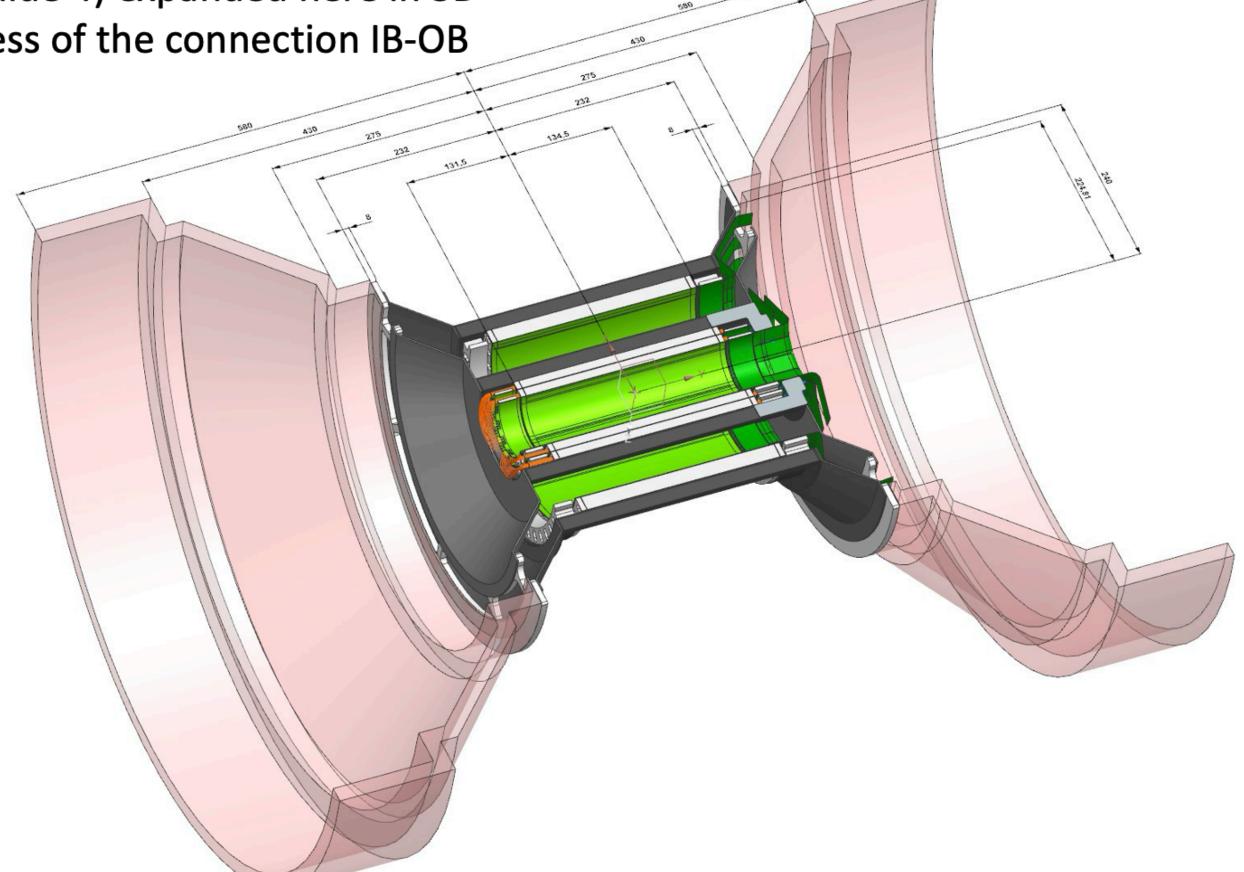
SVT IB connection to OB

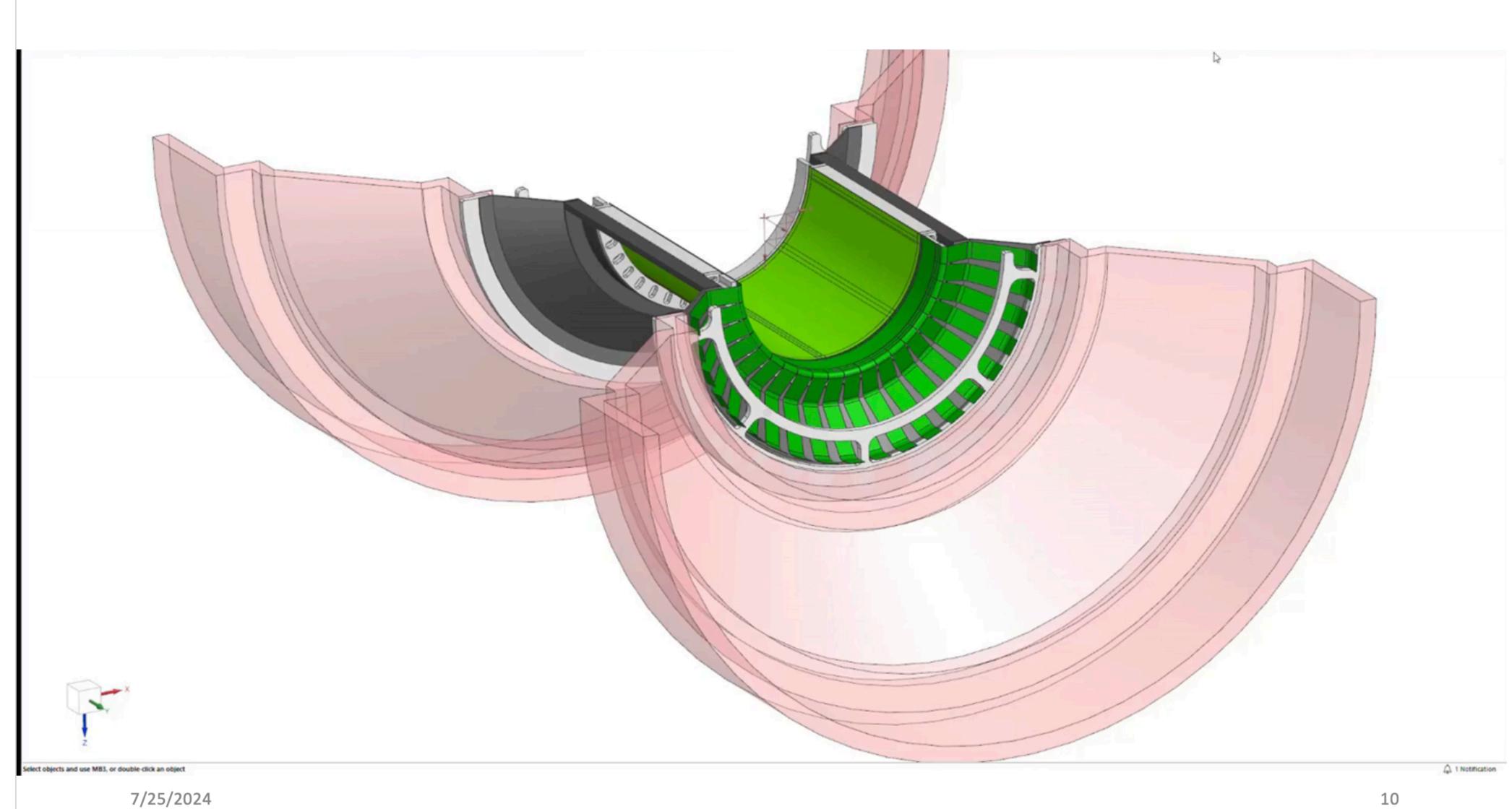


The "first" sketch (slide 4) expanded here in 3D → just for a first guess of the connection IB-OB

L0+L1 on the global support with the flange for L2 support and OB connection







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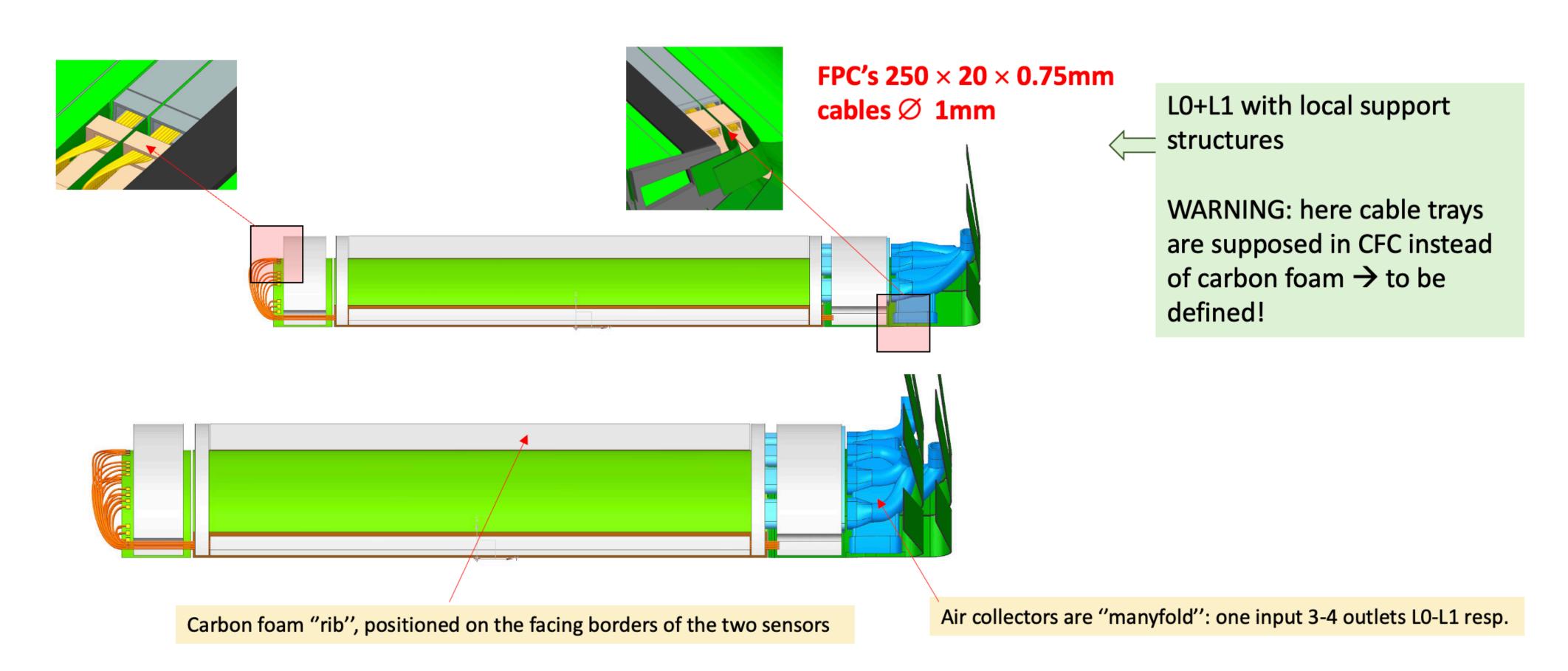
Rosario Turrisi

SVT Workfest — Inner Barrel



LO-L1 local mechanics



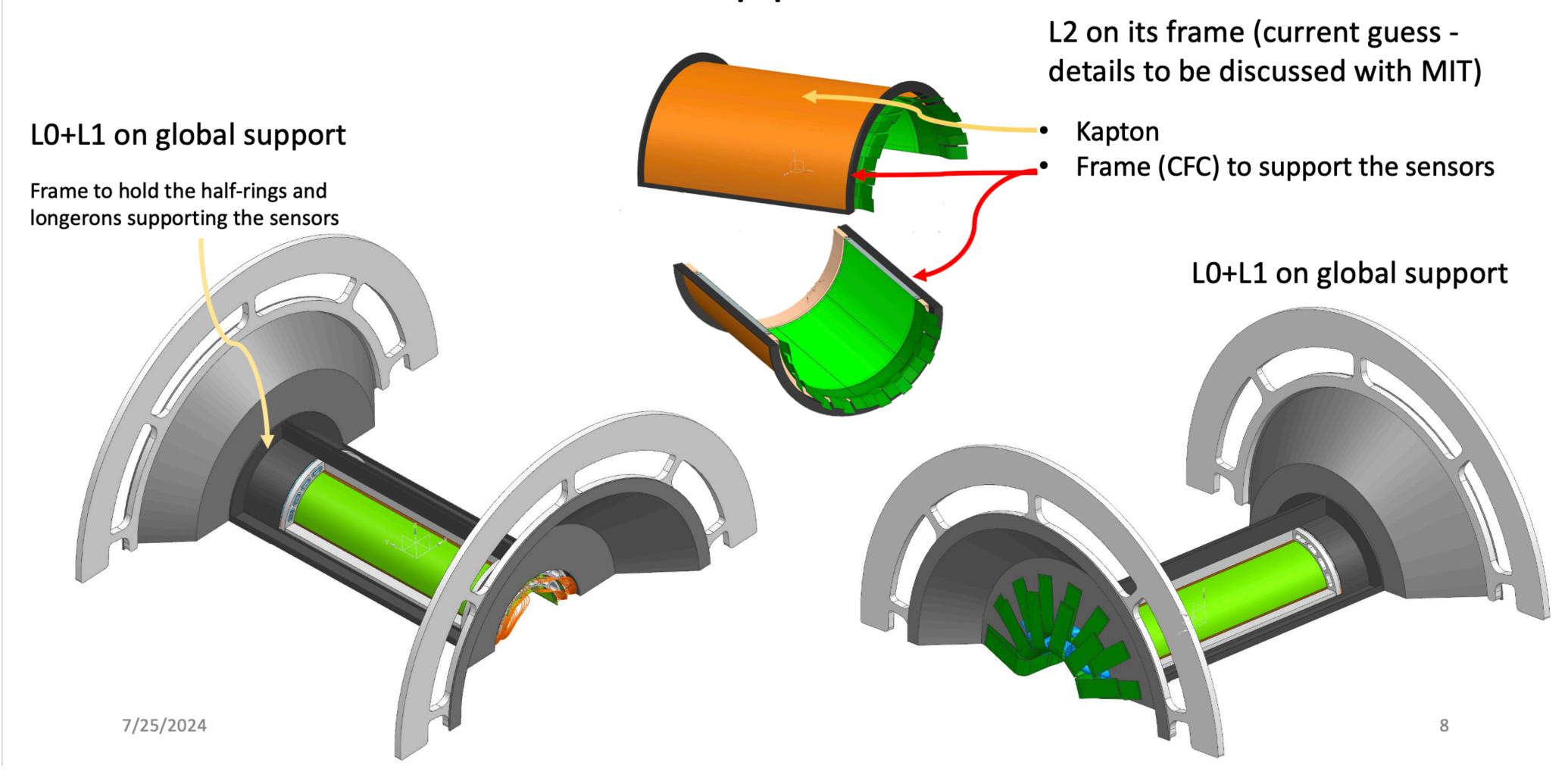


7/25/2024





SVT IB mechanical support L0+L1, L2



3. Prototyping campaign plan



Prototype assembly general goals

- single layer assembly
- L0 and L1 layers connection
- air-cooling mechanism verification

Prototype	Components	Goal
IBL01_P1 (half-layer)	 2 naked silicon L1 sensors L1 local support structure (3-D printed) outer support shell (machined in PEEK) 	finalize half-layer assembly procedure
IBL01_P2 (half-barrel)	 IBL01_P1 + 2 naked silicon L0 sensors L0 local support structure (3-D printed) 	finalize half-barrel assembly procedure
IBL01_P3 (half-layer)	 2 naked silicon L1 sensors L1 local support structure (carbon foam) outer support shell (carbon fiber, to be defined) 	thermal chamber test
IBL01_P4 (half-barrel)	 IBL01_P3 + 2 naked silicon L0 sensors L0 local support structure (carbon foam) 	 thermal chamber test
IBL01_P5 (half-barrel)	 2+2 silicon L0+L1 sensors with heaters from CERN L0+L1 local support structures (carbon foam) outer support shell (carbon fiber, to be defined) air distribution inlet et outlet (to be designed) PT1000 sensors (to be glued on heater surface) 	wind tunnel test

Summer/Fall prototyping campaign:

- · Thermo-mechanical,
- Campaign for entire SVT Inner Barrel, Outer Barrel, and Disks
- Focus in next slides on Inner Barrel,
- Dummy silicon with actual SVT dimensions in hand, thinned and diced, distributed to Italy/CERN, UK, and US.

Domenico Colella

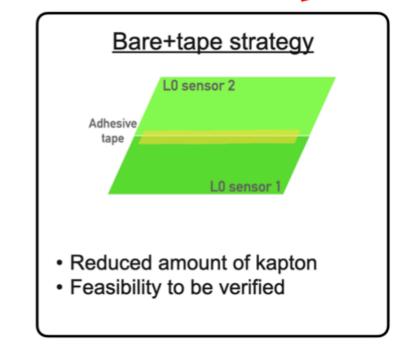
SVT Workfest — Inner Barrel

1. Silicon sensor bending technique

Single object bending

Test conditions:

- 50 μm ALPIDE sensors (30 mm x 15 mm)
- bending radius 18 mm
- adhesive tape thickness: from 12 μm to ~60 μm







Attempt	Adhesive tape thickness	Result	Note
#1	12 µm	breakage	Close to tape-to-mandrel edge
#2	12 µm	success	Cusp at sensors junction
#3	40 µm	success	Reduced cusp
#4	60 µm	breakage	Cusp not reduced wrt 40 µm Breakage (probably) due to already stressed silicon

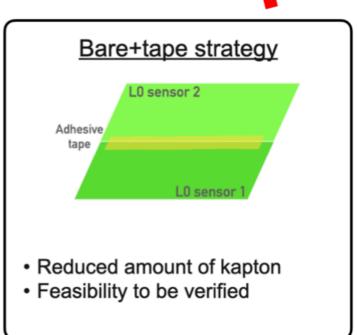
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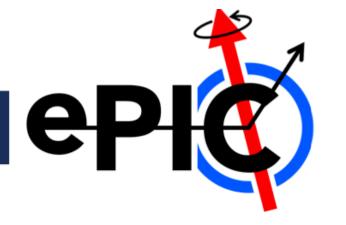




Next tests:

- material: 2 ALPIDE (50 μm) + large size silicon pieces (not regular shape)
- parameter to be explored:
 - adhesive tape thickness: increase to verify reduction of cusp height
 - tape width: present 18 mm (half on each sensor)
- verify effect of support structure in cusp height reduction

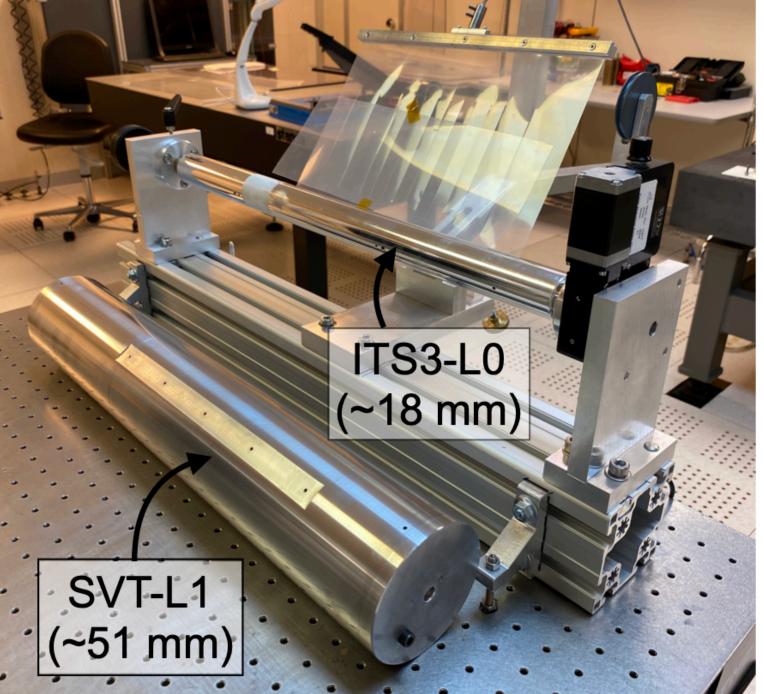
3. Prototyping campaign plan

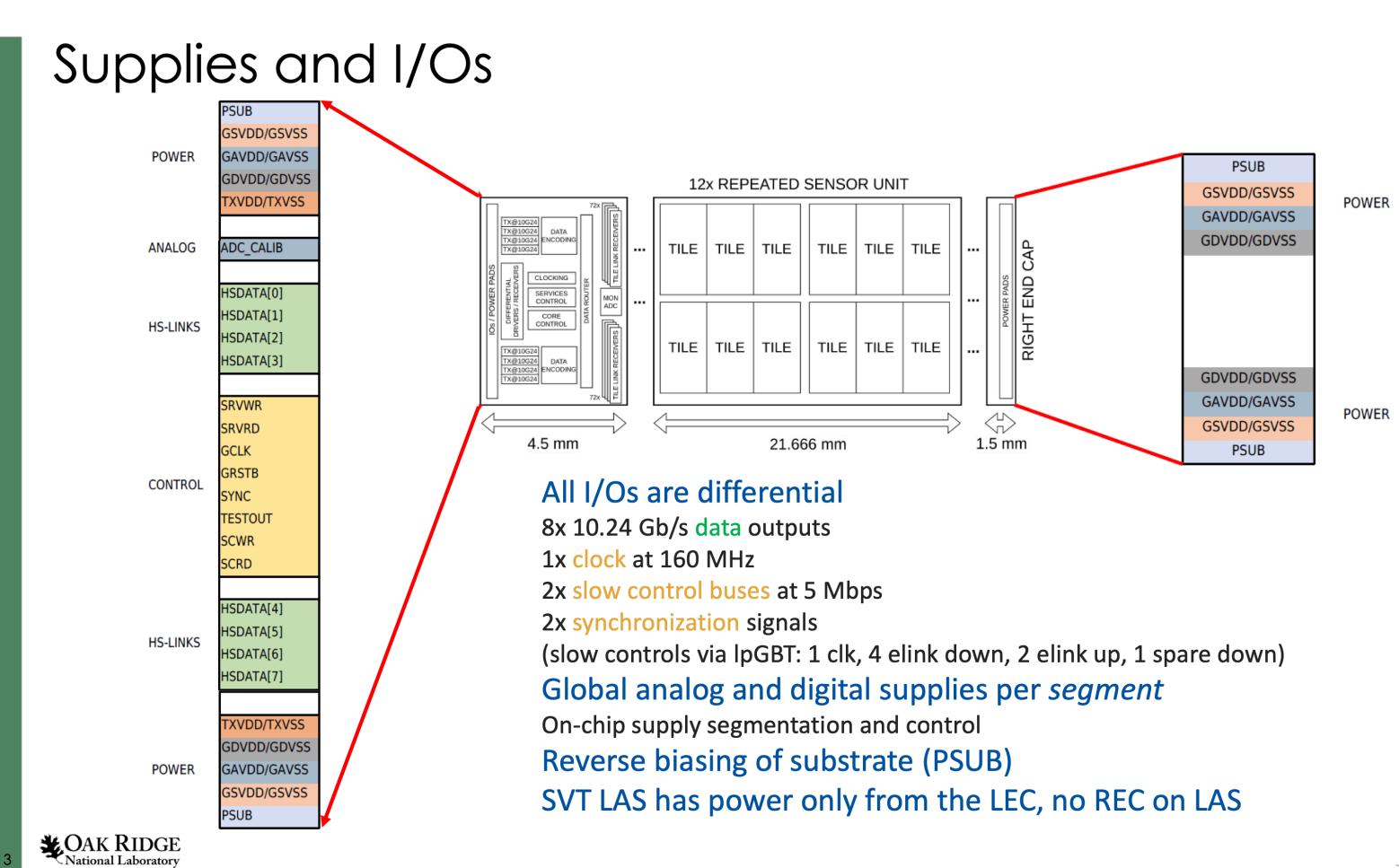


Setup and tools update:

- Dedicated bending setup available
- First version of L1 mandrel available
 - Producer for high quality mandrels identified





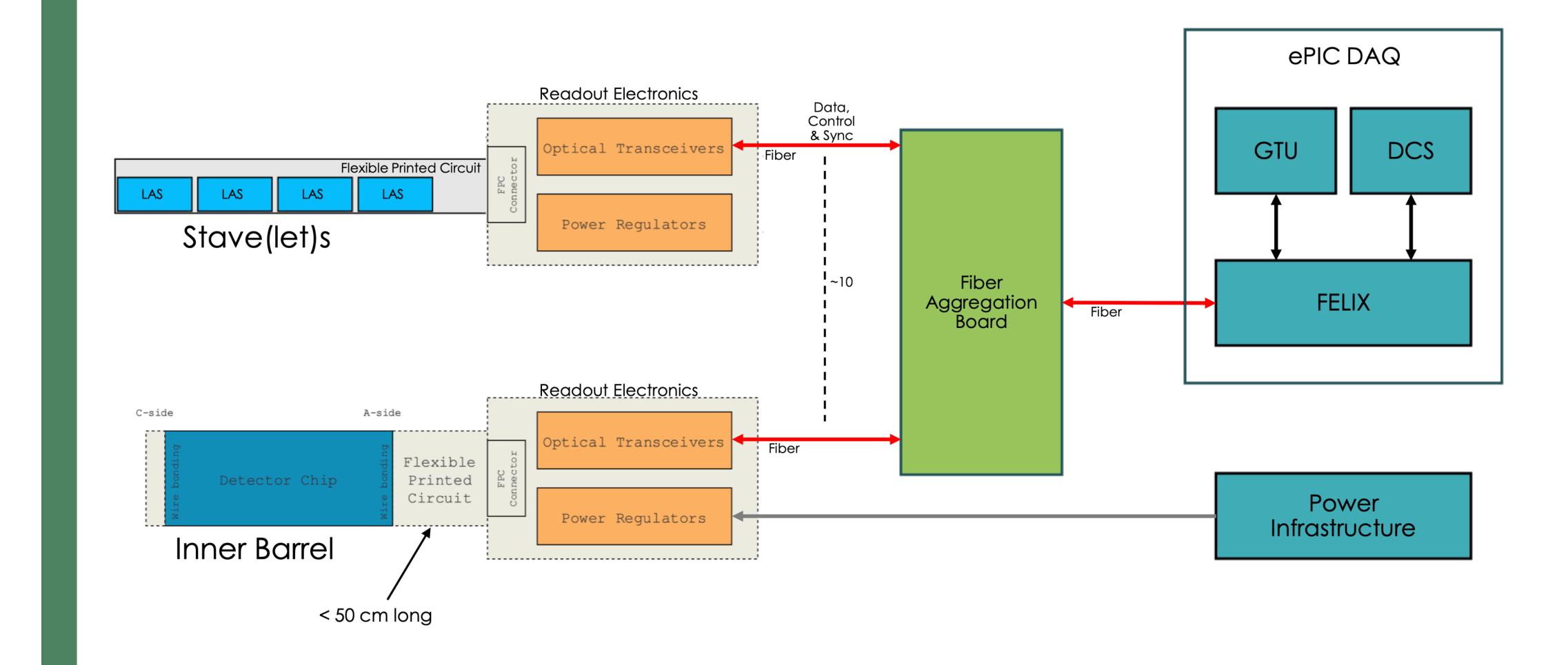


Recall, SVT relies on MOSAIX:

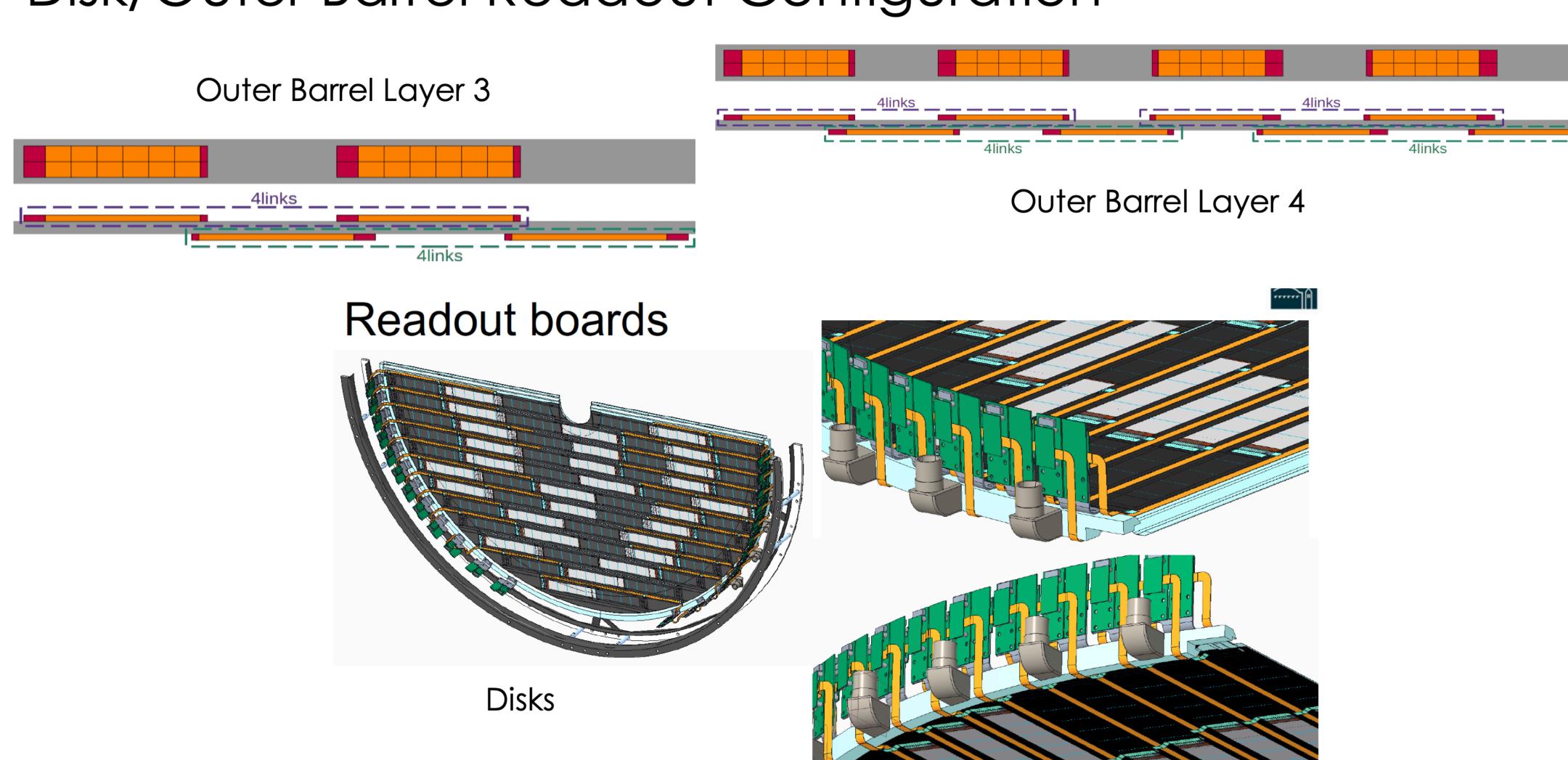
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J. Schambach

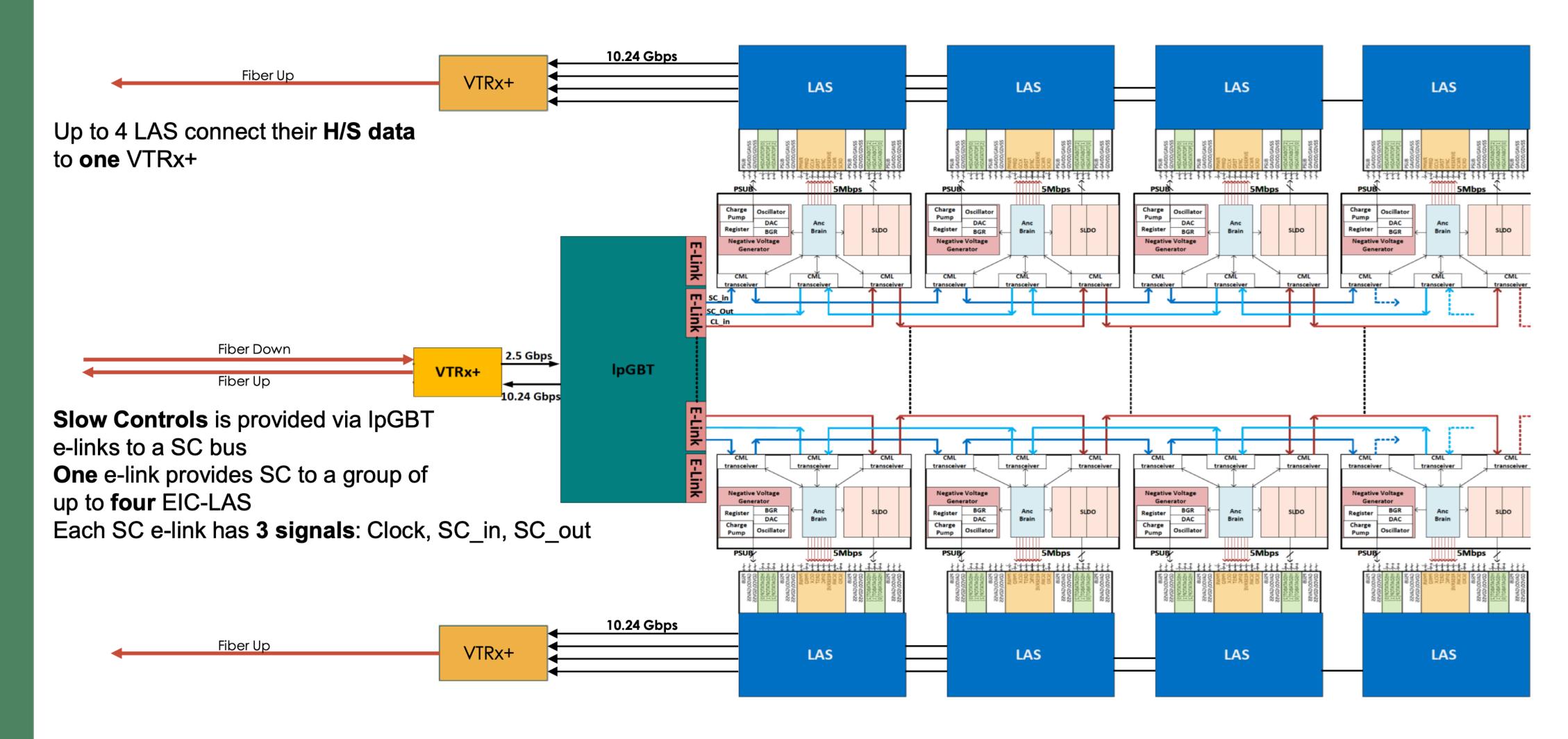
SVT Electronics – Simplified Overview



Disk/Outer Barrel Readout Configuration



Outer Barrel and Disk Readout Electronics



Jo's talk is a treasure trove of information and (follow-up) questions:

How long does it take to run calibration scans?

- Duration largely depend on parallelism
- In final readout system, full parallel scans possible
- Sequential scans probably required for \

	Powering (s)	Matrix configuration (s)	l
Parallel	0.5	121	56
Sequential	72	9212	81
Assumptions:	can		
Threshold se DAC resolut Pulses per s Integration v	tion: 256 settings: 50 window: 100 us en rows: 1000 us		

How long does it take to configure the pixel matrix?

- Pixels configuration via periphery slow control endpoint
- Configuration accomplished by 4 action
 - Set configuration value
 - Select rows
 - Select columns
 - Commit

¥,OAK RIDGE

- Assuming the need to mask 1% of pixels:
- Time to configure 1 tile: 0.028 seconds
- Time to configure a segment: 4 seconds

Configuration Scrubbing & Monitoring

- To ensure that all pixels keep their configuration during a run, the configuration should be updated with regular intervals.
- For scrubbing, individual pixels must be addresses, to avoid overwriting any non-default configuration
- Time to execute scrub cycle 1 tile: 2.8 seconds
- Time to execute scrub cycle segment: 7 minutes
- Tile readout monitoring:
 - Assuming less than 50 registers to monitor per tile
 - < 200 ms per segment</p>

Zhenyu Ye

SVT Workfest — Beam and Irradiation Tests



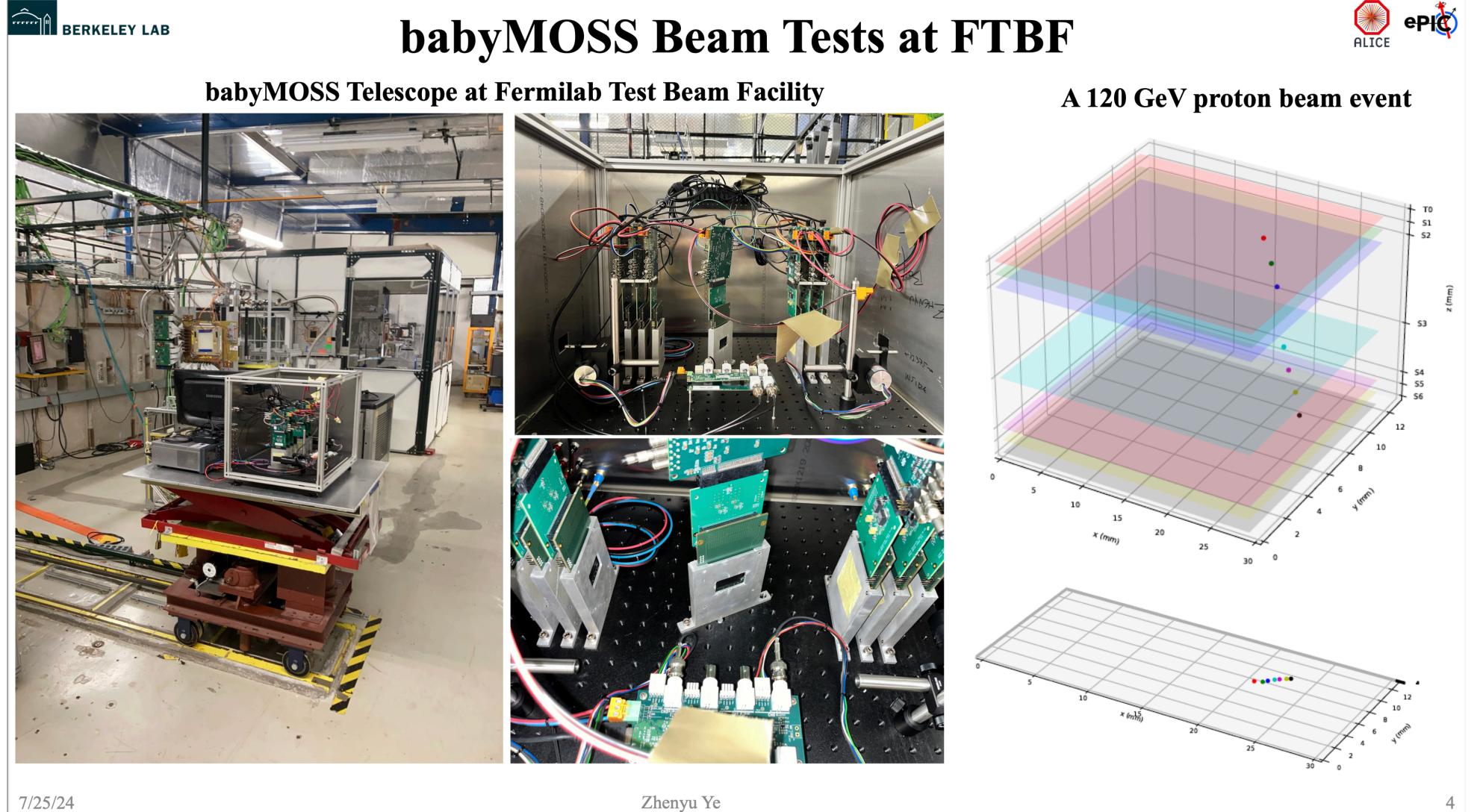
Summary and Outlook



- Beam Tests at Fermilab Test Beam Facility on May22-June 4 and June 26- July12, 2024
 - Assembled and commissioned a 7-plane babyMOSS telescope with 120 GeV protons
 - Studied the dependence of sensor performance on incident angle
 - Data analysis is nearly completed to extract efficiency, resolution, cluster size
- SEE Tests at Berkeley Accelerator Space Effects Facility on May 22-23 and July 1, 2024
 - Measured babyMOSS SEL and DAC register SEU cross-sections as a function of LET
 - Searched for SEL-sensitive circuits on babyMOSS with motion-controlled collimators
 - Data analysis is nearly completed to extract cross-sections and locations of sensitive circuits
- Plan for Winter 2024/Spring 2025: irradiate babyMOSS sensors and study the temperature dependence of pre- and irradiated sensor performance in the lab and with beam

7/25/24 Zhenyu Ye

SVT Workfest — Beam and Irradiation Tests Zhenyu Ye



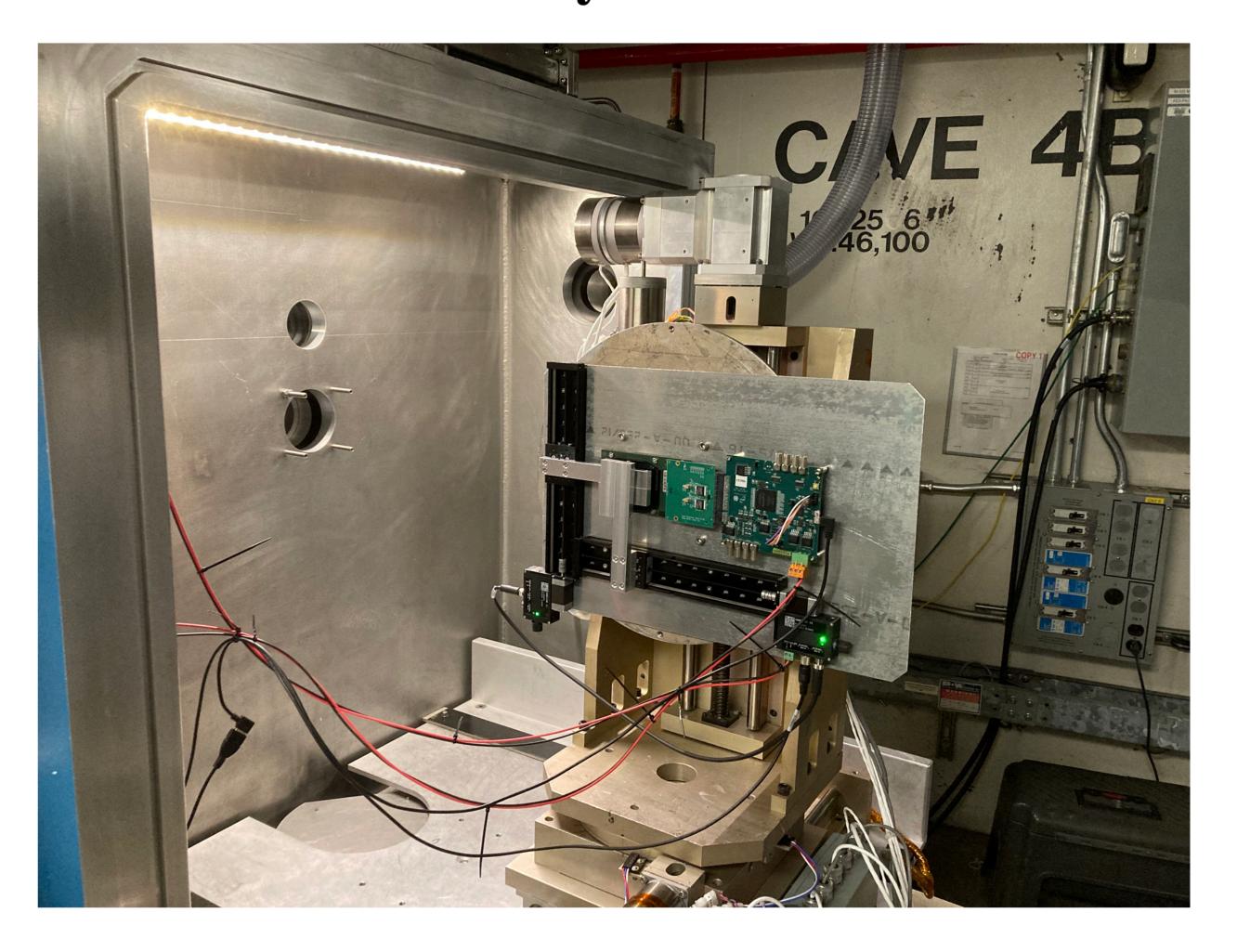
SVT Workfest — Beam and Irradiation Tests Zhenyu Ye



babyMOSS SEE Tests at BASE









Thank you to all who participated,

and in particular also the local organization